

Title (en)
GRAVURE CYLINDER-USE COPPER PLATING METHOD AND DEVICE

Title (de)
VERKUPFERUNGSVERFAHREN UND -VORRICHTUNG FÜR TIEFDRUCKZYLINDER

Title (fr)
PROCEDE ET DISPOSITIF DE CUIVRAGE DE CYLINDRE DE GRAVURE

Publication
EP 1887108 A1 20080213 (EN)

Application
EP 06756465 A 20060523

Priority
• JP 2006310209 W 20060523
• JP 2005152187 A 20050525

Abstract (en)
The present invention provides a copper plating method and apparatus for a gravure cylinder in which copper plating with more uniform thickness can be provided over a full length of a gravure cylinder without causing defects such as rashes and pits irrespective of a size of the gravure cylinder, concentration of a copper plating solution can be managed automatically, a consumption amount of an additive is reduced to make it possible to perform a plating treatment within a short period of time, a power supply cost is reduced, and handling is easy with excellent visibility. A gravure cylinder in a hollow cylindrical shape is held at both ends in a longitudinal direction. The gravure cylinder is accommodated in a plating bath filled with a copper plating solution. The gravure cylinder is energized so that the gravure cylinder functions as a cathode while being rotated at a predetermined speed. A pair of anode chambers in a long box shape, in which insoluble anodes are provided upright slidably to both sides of the gravure cylinder in the plating bath and energized so as to function as an anode, are brought close to both side surfaces of the gravure cylinder at a predetermined interval. Copper plating is provided on an outer peripheral surface of the gravure cylinder.

IPC 8 full level
C25D 17/00 (2006.01); **B41N 3/03** (2006.01); **C25D 7/04** (2006.01); **C25D 21/14** (2006.01)

CPC (source: EP KR US)
B41N 3/032 (2013.01 - EP US); **C25D 5/04** (2013.01 - EP KR US); **C25D 7/04** (2013.01 - KR US); **C25D 17/002** (2013.01 - EP KR US);
C25D 17/008 (2013.01 - EP KR US); **C25D 17/06** (2013.01 - EP KR US); **C25D 17/12** (2013.01 - EP KR US); **C25D 21/06** (2013.01 - EP KR US);
C25D 21/10 (2013.01 - EP KR US); **C25D 21/14** (2013.01 - EP KR US); **C25D 21/18** (2013.01 - EP KR US)

Citation (search report)
See references of WO 2006126518A1

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US9133561B2; US8867101B2; WO2009152915A3

Designated contracting state (EPC)
AT CH DE IT LI

DOCDB simple family (publication)
EP 1887108 A1 20080213; CN 101184870 A 20080521; JP WO2006126518 A1 20081225; KR 20070118694 A 20071217;
US 2009095633 A1 20090416; WO 2006126518 A1 20061130

DOCDB simple family (application)
EP 06756465 A 20060523; CN 200680018346 A 20060523; JP 2006310209 W 20060523; JP 2007517828 A 20060523;
KR 20077025754 A 20071106; US 91325706 A 20060523